

Second Harmonic and Sum-Frequency Generation from Aqueous Interfaces Is Modulated by Interference

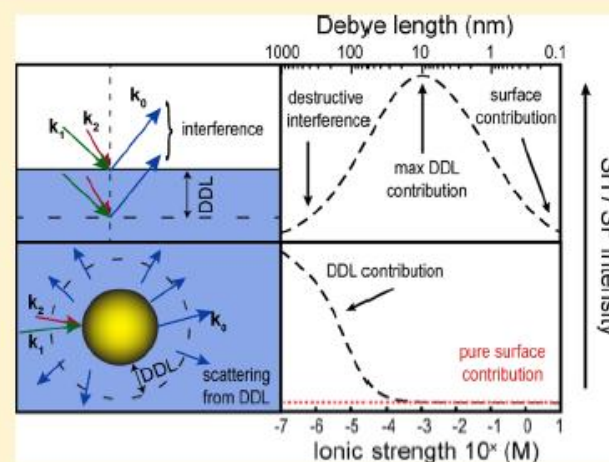
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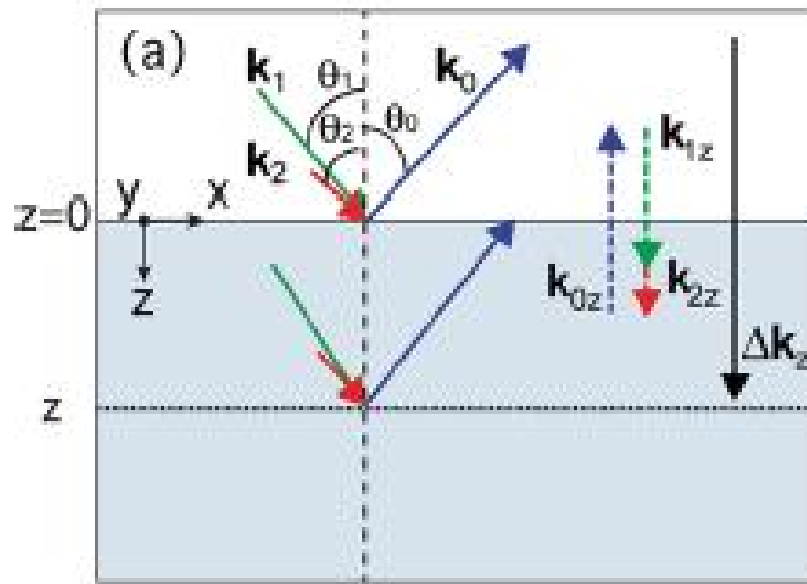
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Supporting Information

ABSTRACT: The interfacial region of aqueous systems also known as the electrical double layer can be characterized on the molecular level with second harmonic and sum-frequency generation (SHG/SFG). SHG and SFG are surface specific methods for isotropic liquids. Here, we model the SHG/SFG intensity in reflection, transmission, and scattering geometry taking into account the spatial variation of all fields. We show that, in the presence of a surface electrostatic field, interference effects, which originate from oriented water molecules on a length scale over which the potential decays, can strongly modify the probing depth as well as the expected intensity at ionic strengths $<10^{-3}$ M. For reflection experiments this interference phenomenon leads to a significant reduction of the SHG/SFG intensity. Transmission mode experiments from aqueous interfaces are hardly influenced. For SHG/SFG scattering experiments the same interference leads to an increase in intensity and to modified scattering patterns. The predicted scattering patterns are verified experimentally.



SH/SF generation at reflection geometry



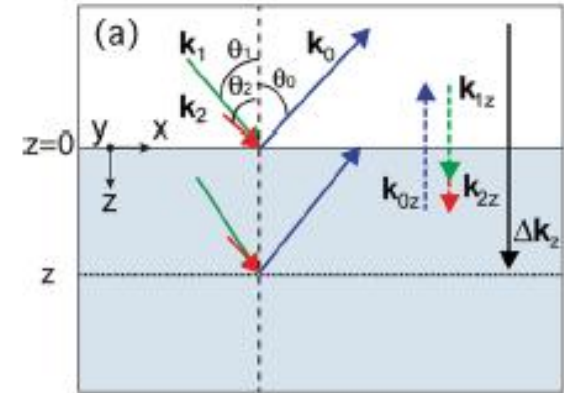
$$n_{1,SFG} = n_{1,VIS} = n_{1,IR} = 1$$

$$n_{2,SFG} > n_{2,VIS} > n_{2,IR}$$

$$\vec{E}(\omega_{SFG} = \omega_{IR} + \omega_{VIS}) \propto \chi^{(2)} : \vec{E}(\omega_{IR}) \vec{E}(\omega_{VIS})$$

$$E_i(\omega_{SFG}) e^{i\vec{k}_{SFG} \cdot \vec{r}} \propto \chi_{ijk}^{(2)} E_j(\omega_{IR}) e^{i\vec{k}_{IR} \cdot \vec{r}} E_k(\omega_{VIS}) e^{i\vec{k}_{VIS} \cdot \vec{r}}$$

SH/SF generation at reflection geometry



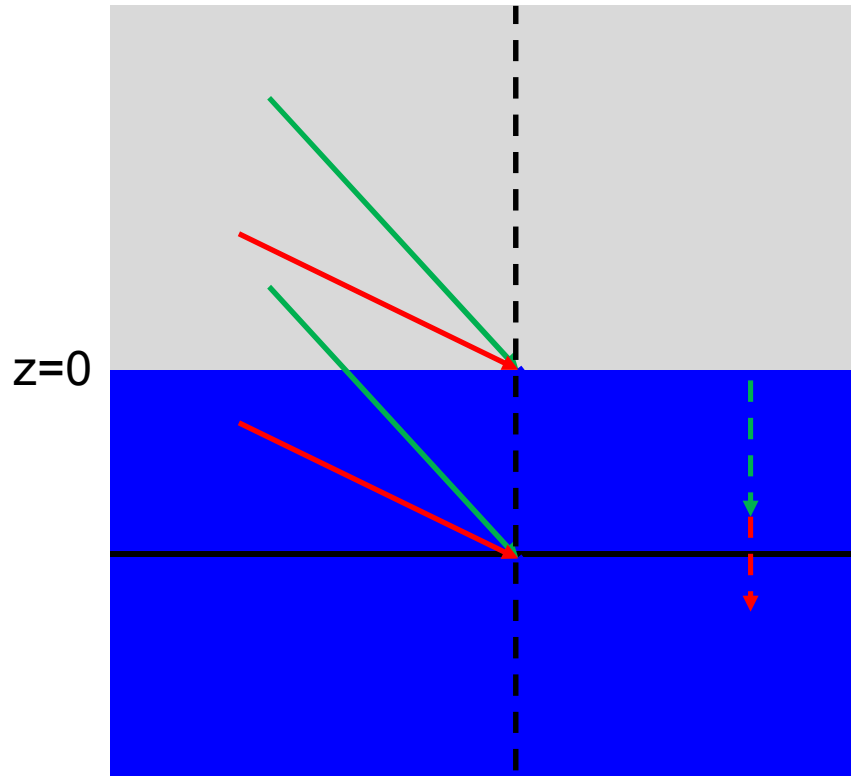
$$\begin{aligned} \Delta k_x &= n_{2,VIS} |k_{VIS}| \sin \theta'_1 + n_{2,IR} |k_{IR}| \sin \theta'_2 - n_{2,SFG} |k_{SFG}| \sin \theta'_0 \\ &= n_{1,VIS} |k_{VIS}| \sin \theta_1 + n_{1,IR} |k_{IR}| \sin \theta_2 - n_{1,SFG} |k_{SFG}| \sin \theta_0 \end{aligned}$$

$$\Delta k_z = n_{2,VIS} |k_{VIS}| \cos \theta'_1 + n_{2,IR} |k_{IR}| \cos \theta'_2 + n_{2,SFG} |k_{SFG}| \cos \theta'_0$$

*Coherence length, l_c is given as,

$$l_{c,r} = \frac{1}{\Delta k_z} = \frac{1}{(n_{2,VIS} |k_{VIS}| \cos \theta'_1 + n_{2,IR} |k_{IR}| \cos \theta'_2 + n_{2,SF} |k_{SF}| \cos \theta'_0)}$$

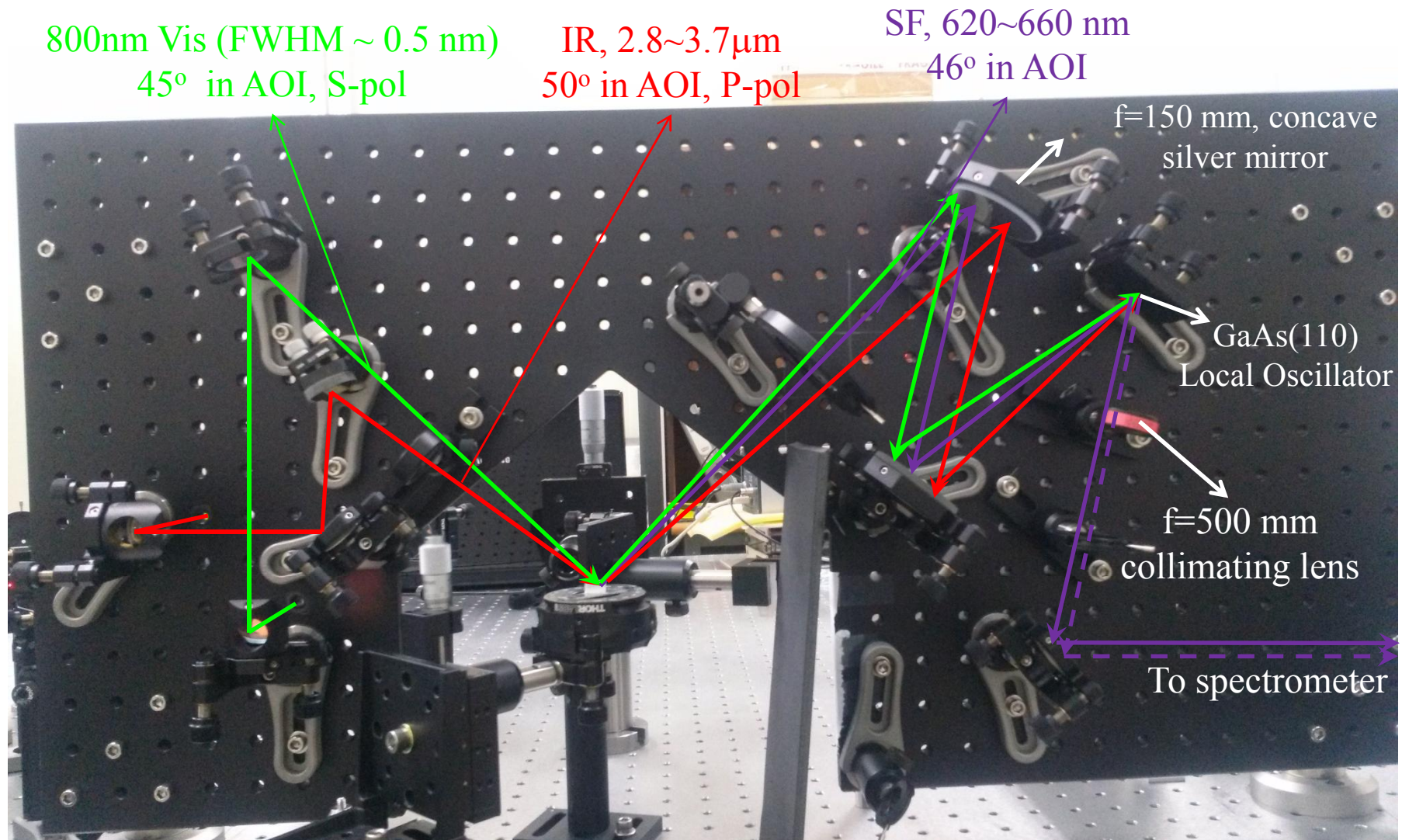
SH/SF generation at transmission geometry



➔

$$l_{c,t} = \frac{1}{\Delta k_z} = \frac{1}{(n_{2,VIS} |k_{VIS}| \cos \theta_1' + n_{2,IR} |k_{IR}| \cos \theta_2' - n_{2,SF} |k_{SF}| \cos \theta_0')} \gg l_{c,r}$$

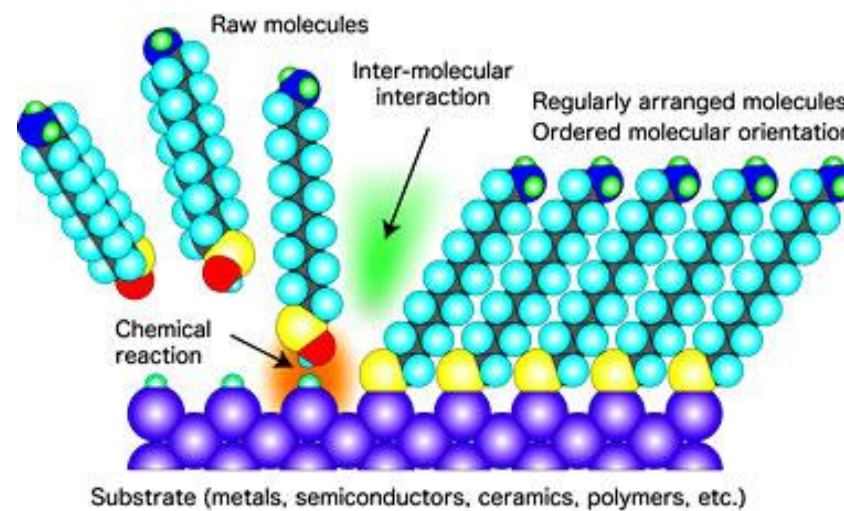
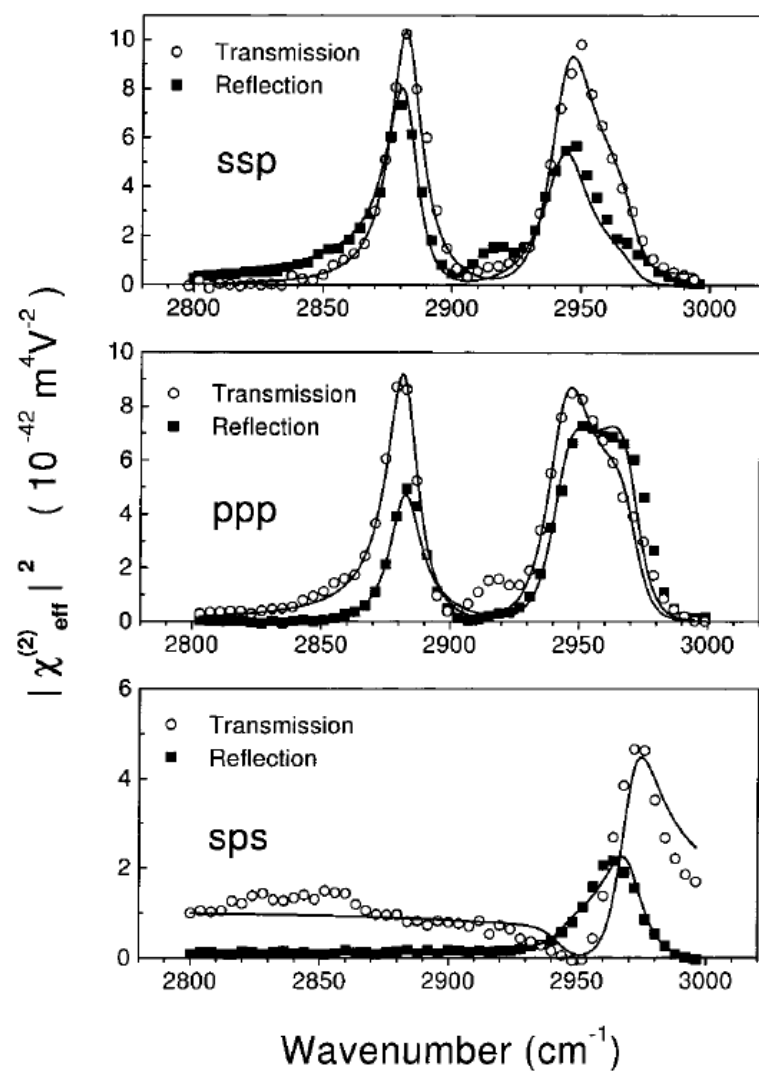
Calculation on our beam geometry



$$l_{c,r} \sim 40 \text{ nm}$$

$$l_{c,t} \sim 12 \mu\text{m}$$

Experimental Examples - OTS monolayer

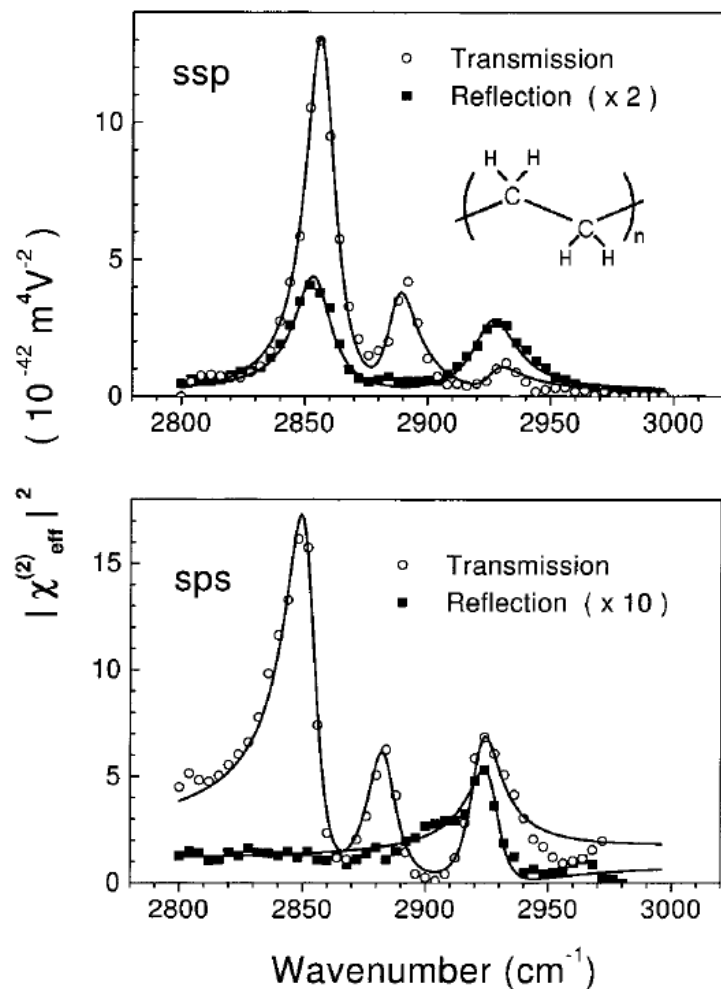


Thickness $\sim 2 - 3$ nm

Figure 2. SFG spectra of an OTS monolayer on fused quartz. Points are experiment data, and the curves are theoretical fits.

Wei et al. J. Phys. Chem. B **2000**, *104*, 3349-3354.

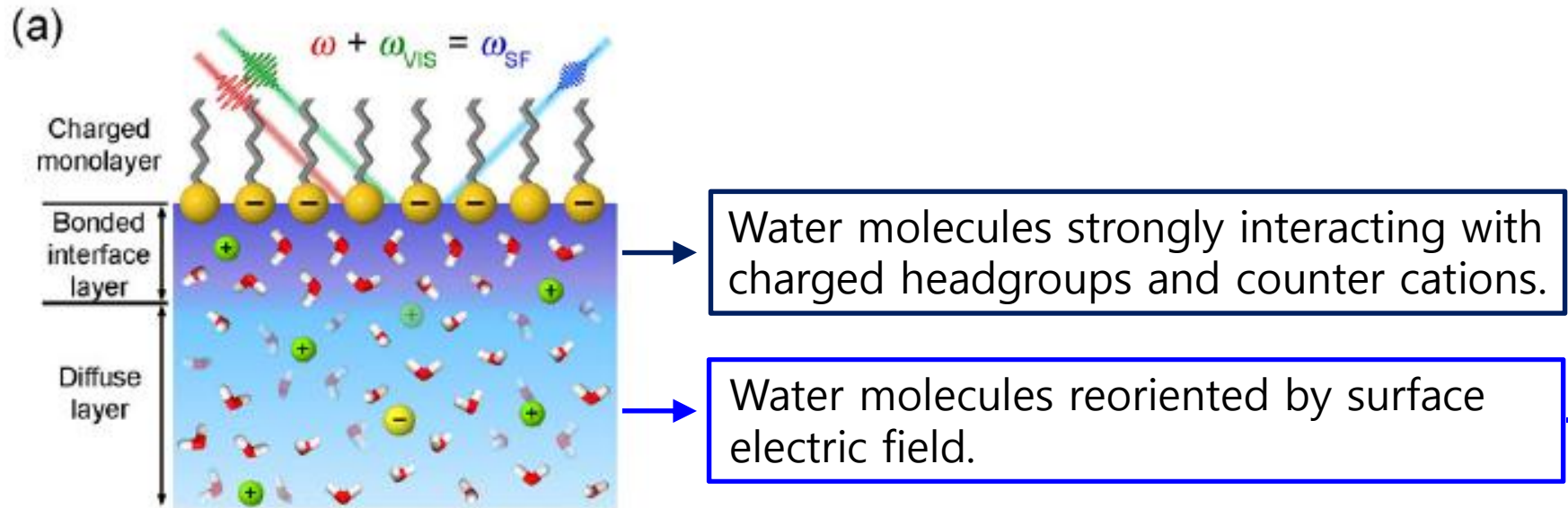
Experimental Example - PE film



Thickness $\sim 200 \mu\text{m}$

Figure 3. SFG spectra of a polyethylene film on fused quartz. The solid curves are theoretical fits.

Interfacial structure model: BIL and DL



Wen et al. *PRL* **2016**, 116, 016101.

$$\chi_{S,\text{eff}}^{(2)} = \chi_S^{(2)} + \int_{0^+}^{\infty} [\chi_B^{(2)} + \chi_B^{(3)} \cdot \hat{z} E_0(z')] e^{i\Delta k_z z'} dz' \quad (1)$$

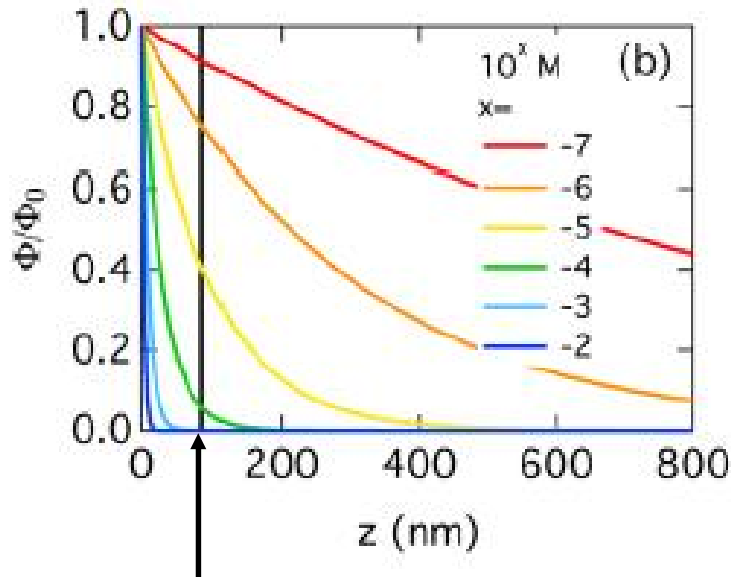
$\chi_S^{(2)}$: Second-order susceptibility of bonded interface layer

$\chi_B^{(2)}$: Second-order electric quadrupole bulk susceptibility

$\chi_B^{(3)}$: Third-order bulk susceptibility

Δk_z : Phase mismatch in reflection geometry ($\Delta k_z = k_{\text{SF},z} - k_{\text{vis},z} - k_{\text{IR},z}$)

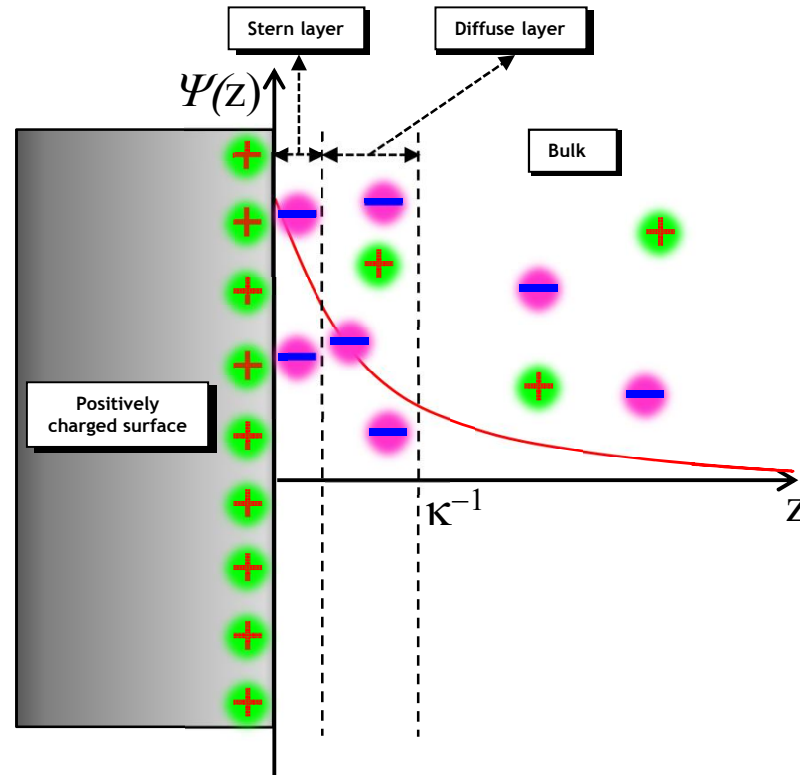
Surface potential profile depending on salt concentration



$$l_{c,r} \sim 90 \text{ nm}$$

Surface SHG (800nm excitation, AOI 45°)

< Gouy-Chapman model >



$$P^{(2)}(\omega_0) = \epsilon_0 \chi_s^{(2)} : E_1(\omega_1) E_2(\omega_2)$$

$$P^{(3)}(\omega_0)$$

$$= \epsilon_0 \int_0^{+\infty} \chi^{(3)} E_1(\omega_1, k_1) E_2(\omega_2, k_2) E_{DC}(z) e^{i\Delta k_z z} dz$$

Considering phase mismatching correction

$$P^{(3)}(\omega_0) = \epsilon_0 \int_0^{+\infty} \chi^{(3)'} E_1(\omega_1, k_1) E_2(\omega_2, k_2) E_{\text{DC}}(z) e^{i\Delta k_z z} dz$$



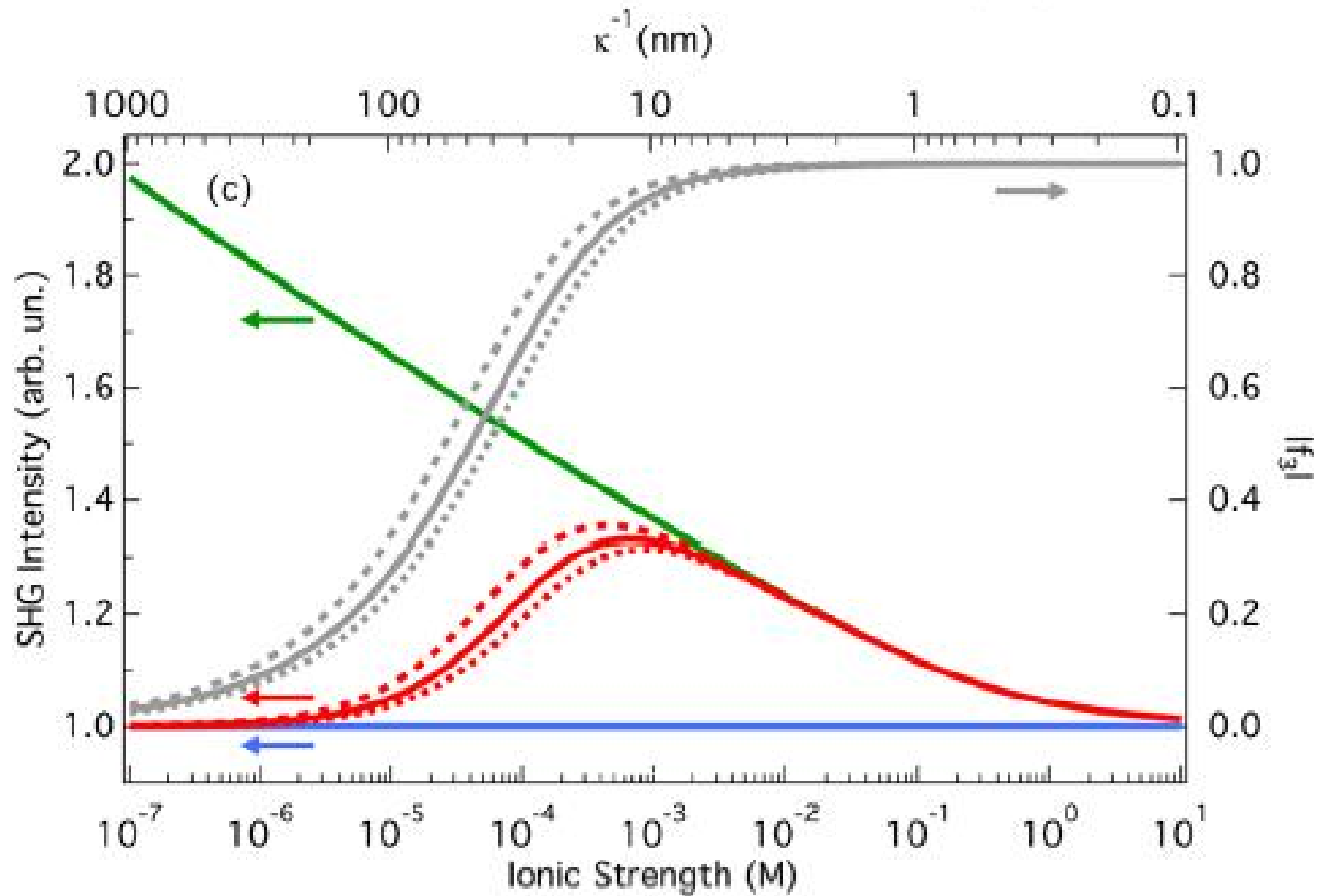
$$P^{(3)}(\omega_0) = \epsilon_0 \chi^{(3)'} E_1(\omega_1) E_2(\omega_2) \int_0^{+\infty} \left(-\frac{d}{dz} \Phi(z) \right) e^{i\Delta k_z z} dz$$



$$P^{(3)}(\omega_0) = \epsilon_0 \chi^{(3)'} E_1(\omega_1) E_2(\omega_2) \left(\Phi_0 + i\Delta k_z \int_0^{+\infty} \Phi(z) e^{i\Delta k_z z} dz \right)$$

Calculation result

$$I(\omega_0) \propto I_1(\omega_1)I_2(\omega_2) \left| \chi_s^{(2)} + \chi^{(3)'} \Phi_0 \frac{\kappa}{\kappa - i\Delta k_z} \right|^2$$



Transmission and scattering geometry

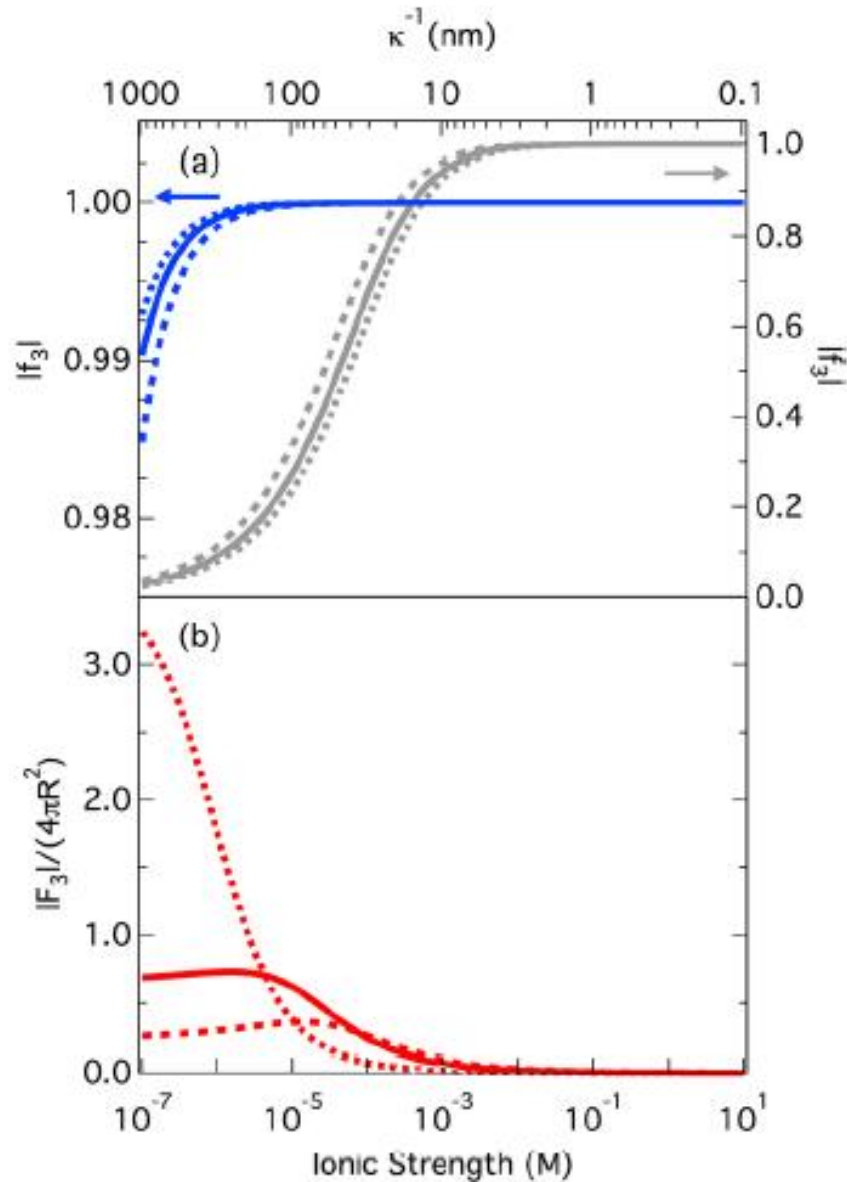
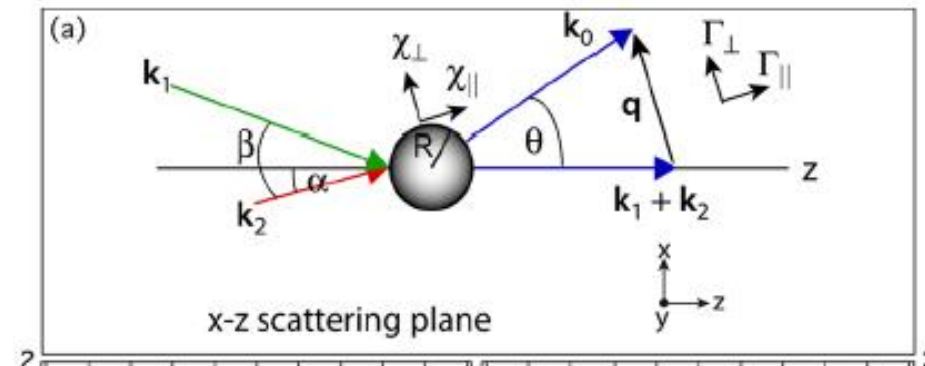
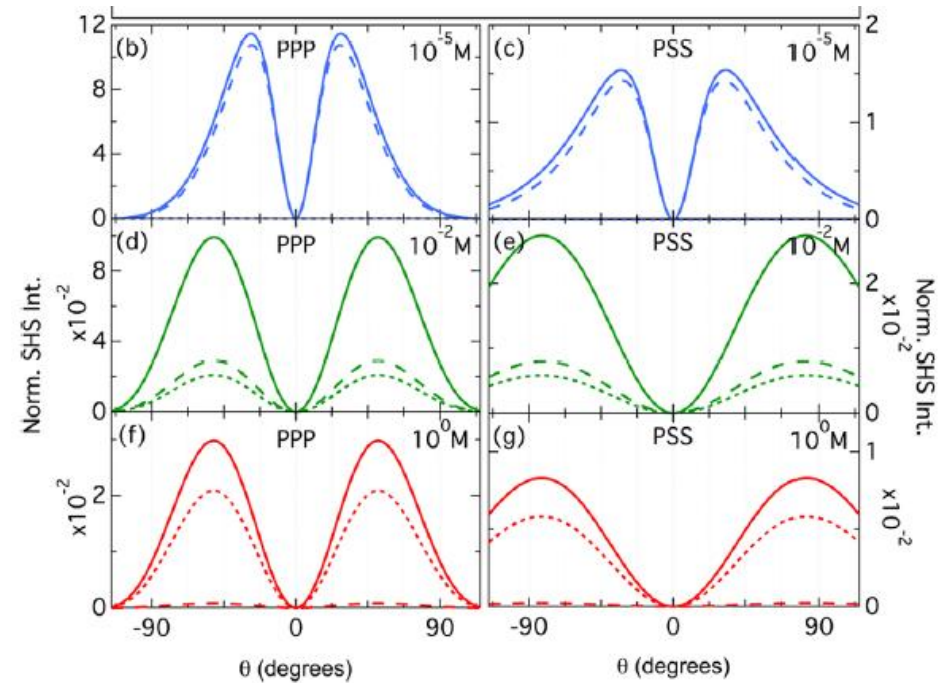
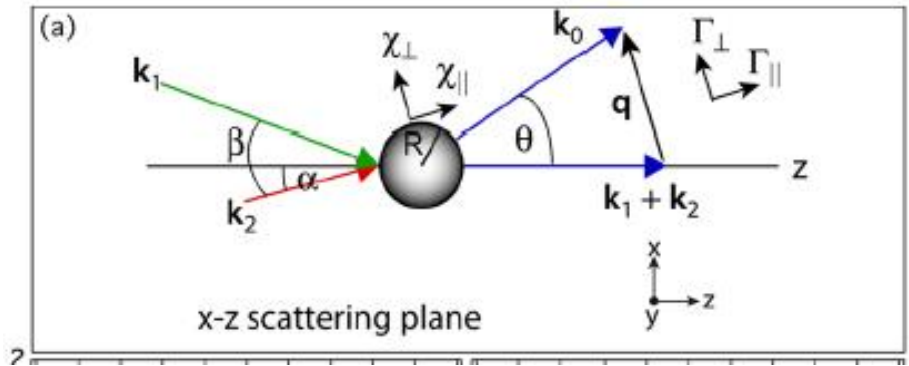


Figure 2. (a) $|f_3(\kappa, \Delta k_z)|$ in transmission geometry (blue continuous curve, left axis) and reflection geometry (gray continuous curve, right axis), as a function of ionic strength. We used the following input values: $\theta_1 = \theta_2 = 45^\circ$, $\lambda_1 = \lambda_2 = 800$ nm, $n_{\text{air}} = 1$, $n_{\text{H}_2\text{O}}(800 \text{ nm}) = 1.33$, and $n_{\text{H}_2\text{O}}(400 \text{ nm}) = 1.34$. The dotted (dashed) line corresponds to curves calculated for $\theta_1 = \theta_2 = 10^\circ$ ($\theta_1 = \theta_2 = 80^\circ$). (b) $|F_3(\kappa R, qR)|/(4\pi R^2)$ for a scattering geometry calculated as a function of ionic strength c . We used the following as parameters: $\theta = 45^\circ$, $\lambda_1 = \lambda_2 = 1028$ nm, $n_{\text{air}} = 1$, $n_{\text{H}_2\text{O}}(1028 \text{ nm}) = 1.33$, and $n_{\text{H}_2\text{O}}(514 \text{ nm}) = 1.33$, and $R = 50$ nm. The continuous, dotted, and dashed lines correspond to curves calculated at scattering angles $\theta = 45^\circ$, 10° , and 80° , respectively.



SFG/SHG scattering

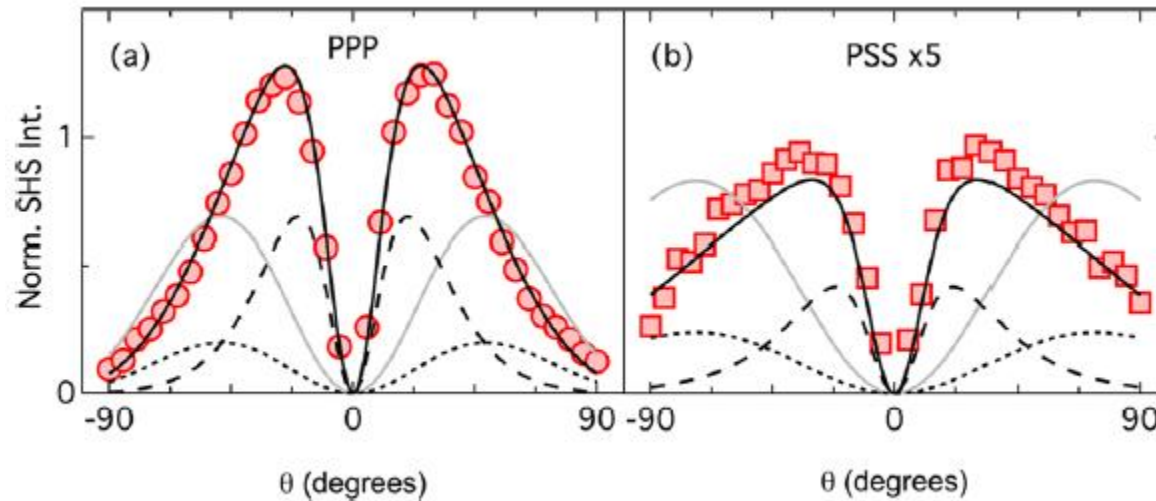


$$\Gamma_n^{(3)'} = - \int_R^{+\infty} \frac{d\Phi(r)}{dr} \Gamma_n^{(3)}(r) dr$$

$$= 2F_1(qR) \Phi_0 \chi_n^{(3)'} + 2\chi_n^{(3)'} \int_R^{+\infty} \frac{dF_1(qr)}{dr} \Phi(r) dr \quad \Phi(r) = \Phi_0 \frac{R}{r} e^{-\kappa(r-R)}$$

$$\Gamma_n^{(3)'} = 2\Phi_0 \chi_n^{(3)'} (F_1(qR) + F_3(\kappa R, qR)) \quad F_3(\kappa R, qR) = 2\pi R^2 i \frac{qR \cos(qR) + \kappa R \sin(qR)}{(qR)^2 + (\kappa R)^2}$$

SHG scattering measurement



Zeta potential measurement :
-37 mV of surface potential

Figure 4. SHS intensity patterns of hexanol-covered hexadecane droplets in ultrapure water for (a) PPP and (b) PSS polarization combinations. The best fit (black line) was achieved using eq 17 for $\Gamma^{(3)'}$, i.e., using the contribution of $F_3(\kappa R, qR)$ to describe the behavior at low ionic strength. The gray line represents the best fit without the $F_3(\kappa R, qR)$ correction, i.e., using eq 15 for $\Gamma^{(3)'}$. The intensities originating from a pure surface response, $\chi_s^{(3)'}$, and pure bulk response, $\chi_s^{(2)}$, are displayed as dotted and dashed lines, respectively.